
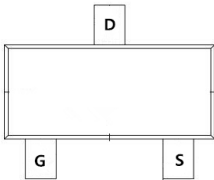


TM03N10BI

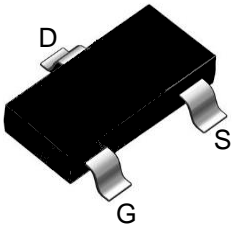
N-Channel Enhancement Mosfet

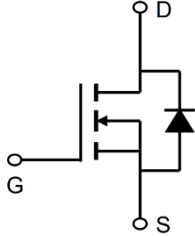
<p>General Description</p> <ul style="list-style-type: none"> • Low R_{DS(ON)} • RoHS and Halogen-Free Compliant <p>Applications</p> <ul style="list-style-type: none"> • Load switch • PWM 	<p>General Features</p> <p>V_{DS} = 100V I_D = 2.8A</p> <p>R_{DS(ON)} = 220mΩ(typ.) @ V_{GS} = 10V</p> <p>100% UIS Tested 100% R_g Tested</p> 
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Marking: 1002 OR 3N10

I: SOT-23





Absolute Maximum Ratings (T_A=25°C unless otherwise specified)

Symbol	Parameter	Max.	Units
V _{DSS}	Drain-Source Voltage	100	V
V _{GSS}	Gate-Source Voltage	±20	V
I _D	Continuous Drain Current	T _A = 25°C	2.8 A
		T _A = 100°C	1.6 A
I _{DM}	Pulsed Drain Current ^{note1}	8.5	A
P _D	Power Dissipation	T _A = 25°C	2.3 W
R _{θJA}	Thermal Resistance, Junction to Ambient	54	°C/W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C



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Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	100	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=100V, V_{GS}=0V$	-	-	1.0	μA
I_{GSS}	Gate to Body Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$	-	-	± 100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	1.5	2.2	V
$R_{DS(on)}$	Static Drain-Source on-Resistance note2	$V_{GS}=10V, I_D=2A$	-	220	250	m Ω
		$V_{GS}=4.5V, I_D=1A$	-	255	280	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=25V, V_{GS}=0V,$ $f=1.0MHz$	-	321	-	pF
C_{oss}	Output Capacitance		-	21	-	pF
C_{rss}	Reverse Transfer Capacitance		-	15	-	pF
Q_g	Total Gate Charge	$V_{DS}=30V, I_D=2A,$ $V_{GS}=10V$	-	5.3	-	nC
Q_{gs}	Gate-Source Charge		-	1.3	-	nC
Q_{gd}	Gate-Drain("Miller") Charge		-	1.7	-	nC
Switching Characteristics						
$t_{d(on)}$	Turn-on Delay Time	$V_{DS}=30V,$ $I_D=1A, R_{GEN}=3\Omega,$ $V_{GS}=10V$	-	14	-	ns
t_r	Turn-on Rise Time		-	54	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	18	-	ns
t_f	Turn-off Fall Time		-	11	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain to Source Diode Forward Current		-	-	3.0	A
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	8.8	A
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS}=0V, I_S=2.2A$	-	-	1.2	V

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

2. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$



Typical Performance Characteristics

Figure 1: Output Characteristics

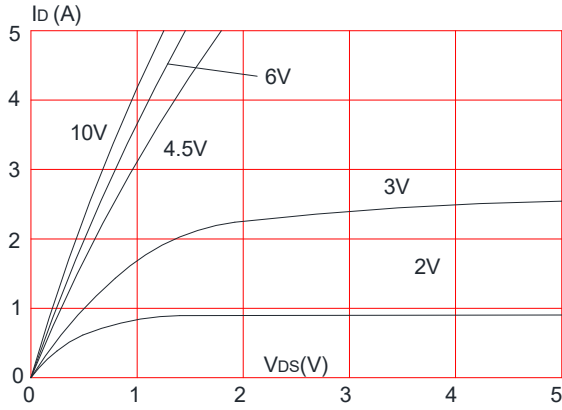


Figure 2: Typical Transfer Characteristics

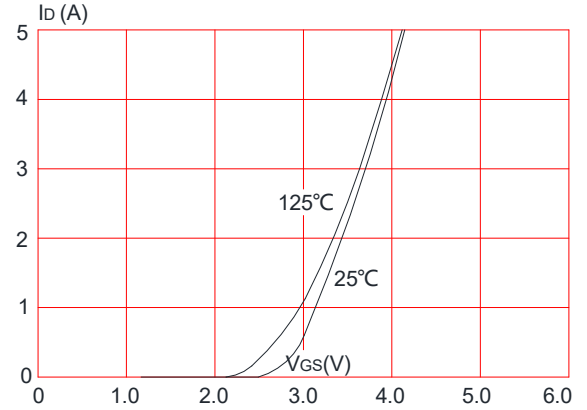


Figure 3: On-resistance vs. Drain Current

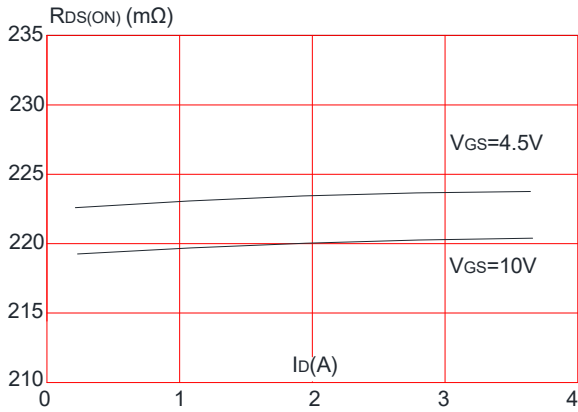


Figure 4: Body Diode Characteristics

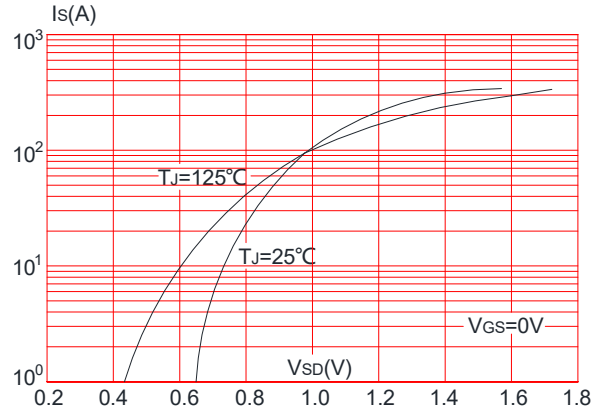


Figure 5: Gate Charge Characteristics

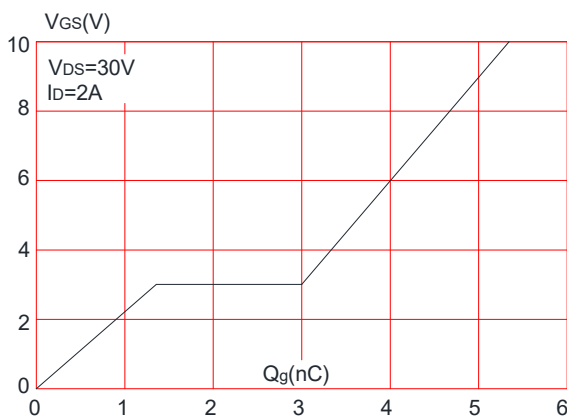
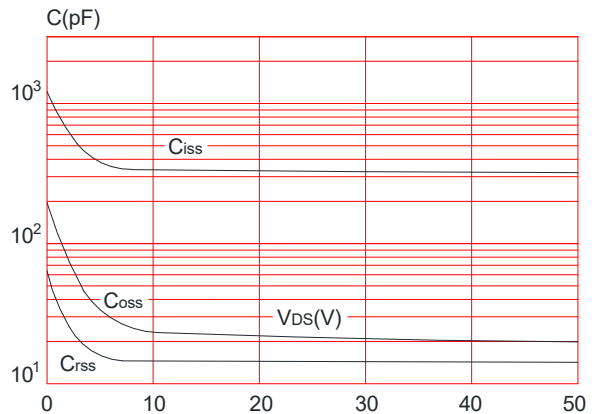


Figure 6: Capacitance Characteristics



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Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

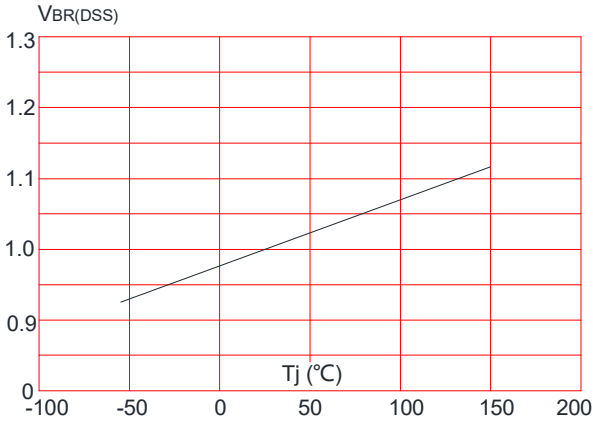


Figure 8: Normalized on Resistance vs. Junction Temperature

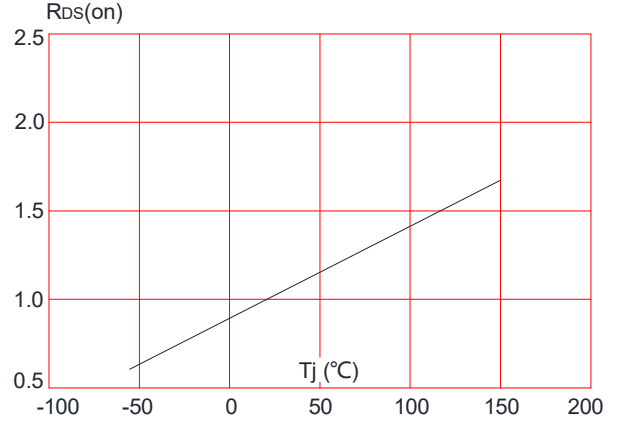


Figure 9: Maximum Safe Operating Area

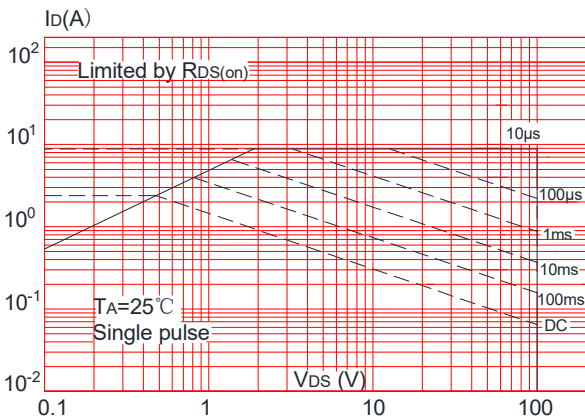


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

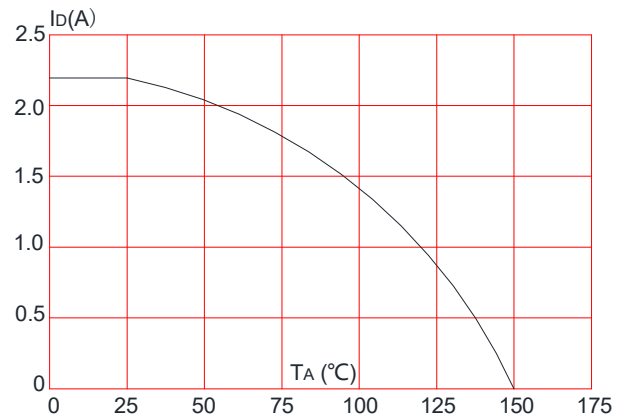
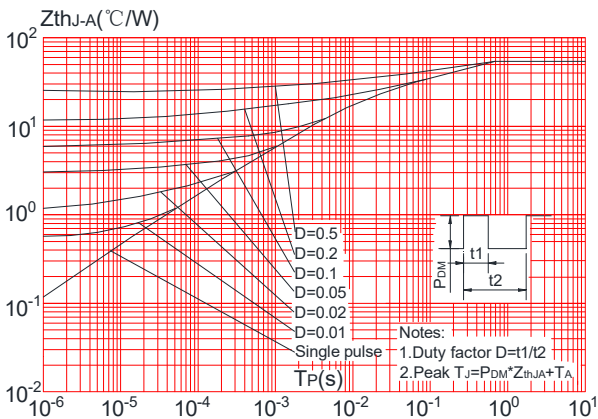


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



Test Circuit

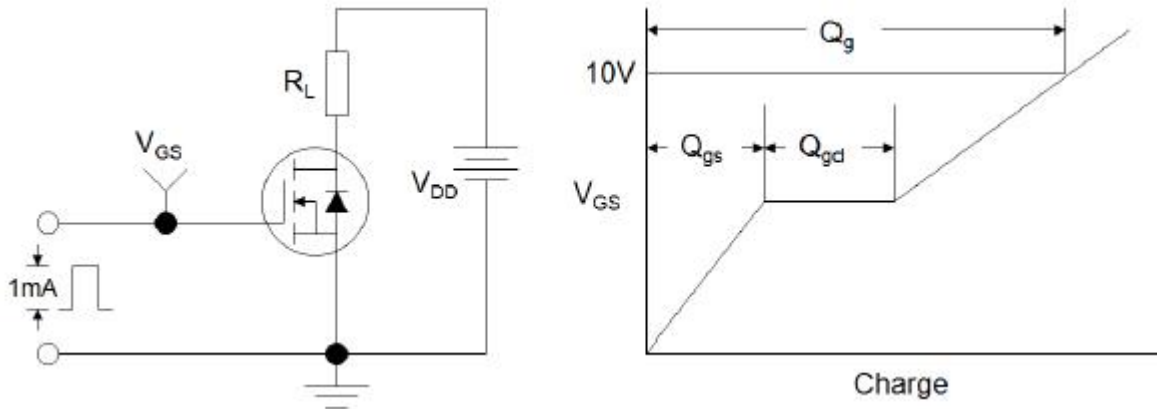


Figure1:Gate Charge Test Circuit & Waveform

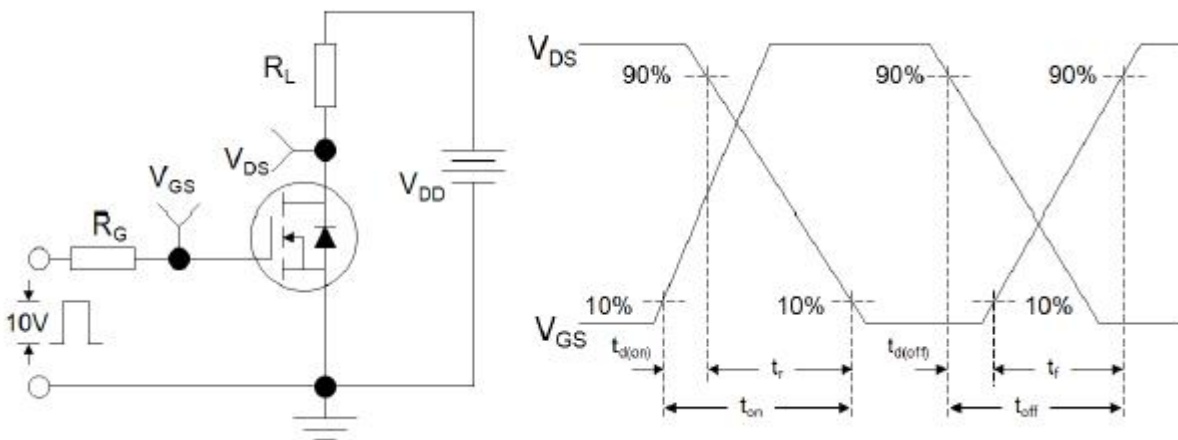


Figure 2: Resistive Switching Test Circuit & Waveforms

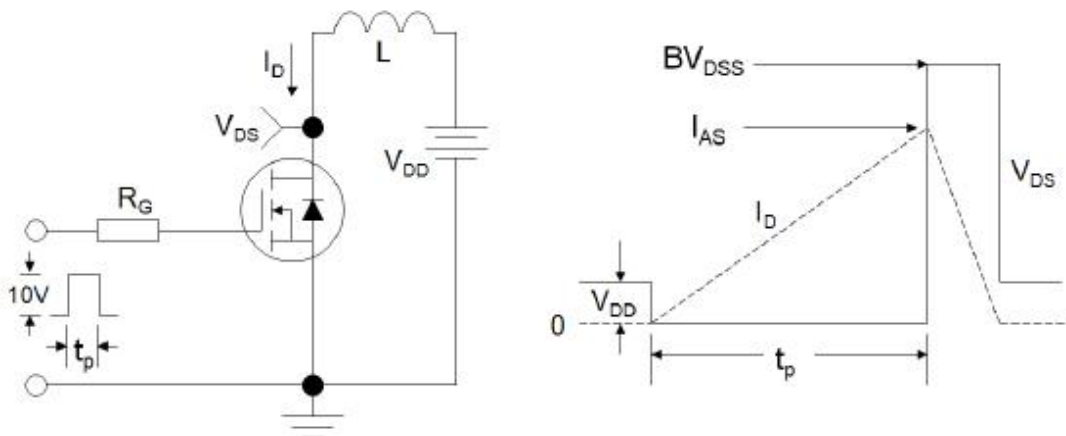
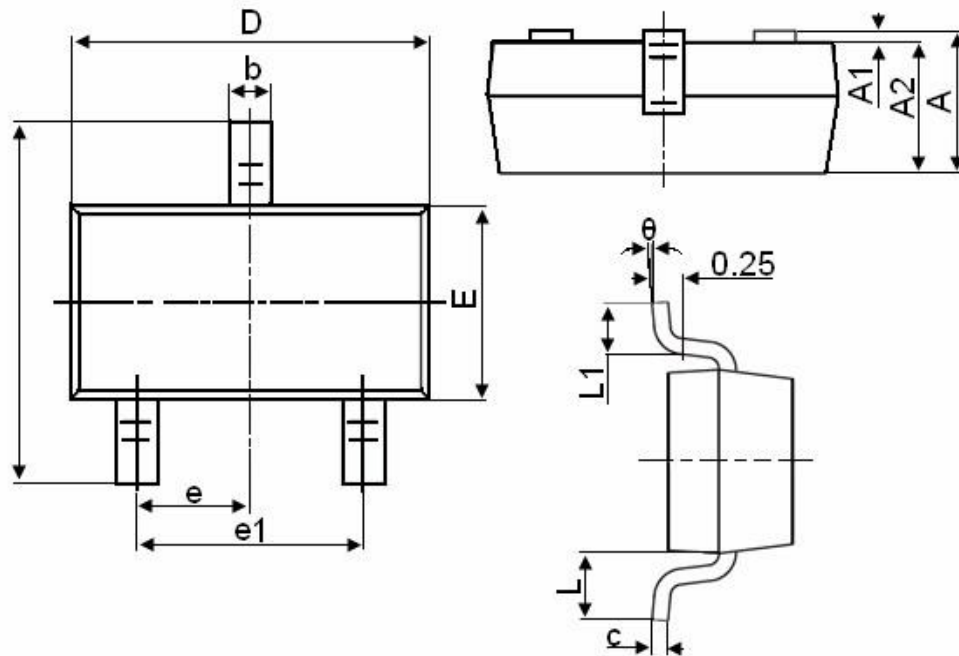


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms

Package Mechanical Data: SOT-23



Symbol	Dimensions in Millimeters	
	MIN.	MAX.
A	0.900	1.150
A1	0.000	0.100
A2	0.900	1.050
b	0.300	0.500
c	0.080	0.150
D	2.800	3.000
E	1.200	1.400
E1	2.250	2.550
e	0.950TYP	
e1	1.800	2.000
L	0.550REF	
L1	0.300	0.500
θ	0°	8°